TOSHIBA 2SD2387

TOSHIBA TRANSISTOR SILICON NPN TRIPLE DIFFUSED TYPE (DARLINGTON POWER TRANSISTOR)

2 S D 2 3 8 7

POWER AMPLIFIER APPLICATIONS

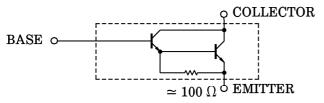
High Breakdown Voltage: VCEO = 140 V (Min.)

Complementary to 2SB1558

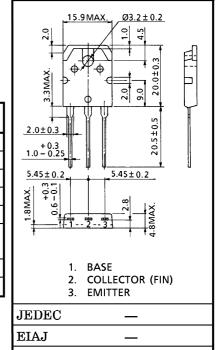
MAXIMUM RATINGS (Ta = 25°C)

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CHARACTERISTIC	SYMBOL	RATING		
Collector-Base Voltage	v_{CBO}	140	V	
Collector-Emitter Voltage	VCEO	140	V	
Emitter-Base Voltage	V_{EBO}	5	V	
Collector Current	IC	8	A	
Base Current	$I_{\mathbf{B}}$	0.1	A	
Collector Power Dissipation	Pa	80	w	
$(Tc = 25^{\circ}C)$	PC	80	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	
Junction Temperature	T_{j}	150	°C	
Storage Temperature Range	$T_{ m stg}$	-55~150	°C	

EQUIVALENT CIRCUIT



Unit in mm



2-16C1A

Weight: 4.7 g

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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	I_{CBO}	$V_{CB} = 140 \text{ V}, I_{E} = 0$	<u> </u>	_	5.0	μ A
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5 \text{ V}, I_{C} = 0$	_	_	5.0	μ A
Collector-Emitter Breakdown Voltage	V (BR) CEO	$I_{\rm C} = 50 {\rm mA}, I_{\rm B} = 0$	140	_	_	V
DC Current Gain	hFE (1) (Note)	$ m V_{CE} = 5~V,~I_{C} = 7~A$	5000	_	30000	
	h _{FE (2)}	$V_{CE} = 5 V, I_{C} = 12 A$	2000	_	_	
Collector-Emitter Saturation Voltage	V _{CE} (sat)	$I_{\mathrm{C}}=7\mathrm{A},~I_{\mathrm{B}}=7\mathrm{mA}$	_	_	2.5	V
Base-Emitter Voltage	$ m V_{BE}$	$V_{CE} = 5 \text{ V}, I_{C} = 7 \text{ A}$	_	_	3.0	V
Transition Frequency	f_{T}	$V_{CE} = 5 \text{ V}, I_{C} = 1 \text{ A}$	_	30	_	MHz
Collector Output Capacitance	$C_{ m ob}$	$V_{CB} = 10 \text{ V}, I_{E} = 0, f = 1 \text{ MHz}$	_	110	_	pF

Note: hFE(1) Classification A: 5000~12000, B: 9000~18000, C: 15000~30000

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